

# **Bipolar Transistors**

## **Description**

This document describes the terms used in data sheets bipolar transistors.



### **Table of Contents**

Description	1
Table of Contents	2
1. Glossary	3
1.1. Absolute maximum ratings	3
1.2. Electrical Characteristics	4
1.3. Other terms	7
RESTRICTIONS ON PRODUCT LISE	8



## 1. Glossary

#### 1.1. Absolute maximum ratings

Term	Symbol	Description	
Collector-base voltage	V <sub>CBO</sub>	The maximum allowable voltage between the collector and base terminals when the emitter terminal is open-circuited	
Collector-emitter voltage	V <sub>CEO</sub>	The maximum allowable voltage between the collector and emitter terminals when the base terminal is open-circuited	
	V <sub>CER</sub>	The maximum allowable voltage between the collector and emitter terminals when a resistor is connected between the base and emitter terminals	
	V <sub>CEX</sub>	The maximum allowable voltage in the cut-off state between the collector and emitter terminals with reverse bias applied between the base and emitter terminals	
	V <sub>CES</sub>	The maximum allowable voltage between the collector and emitter terminals in the cut-off state when the base and emitter terminals are short-circuited	
Emitter-base voltage	V <sub>EBO</sub>	The maximum allowable voltage in the cut-off state between the emitter and base terminals when the collector terminal is open-circuited	
Collector current (DC)	$I_{C}$	The maximum allowable continuous current into the collector terminal	
Collector current (pulsed)	I <sub>CP</sub>	The maximum allowable pulsed current into the collector terminal	
Emitter current	I <sub>E</sub>	The maximum allowable continuous current into the emitter terminal	
Base current	Ι <sub>Β</sub>	The maximum allowable continuous current into the base terminal	
Collector power dissipation	P <sub>C</sub>	The maximum allowable power dissipated across the collector and emitter terminals	
Junction temperature	Tj	The maximum allowable temperature at the junction of the transistor	
Storage temperature	T <sub>stg</sub>	The ambient temperature range over which the device, without any voltage applied, can be stored and transported	



#### 1.2. Electrical Characteristics

Term	Symbol	Description	
Collector-base breakdown voltage	V <sub>(BR)CBO</sub>	The breakdown voltage between the collector and base terminals under specified test conditions when the emitter terminal is open-circuited	
Collector-emitter breakdown voltage	V <sub>(BR)(CEO)</sub>	The breakdown voltage between the collector and emitter terminals under specified test conditions when the base terminal is open-circuited	
	V <sub>(BR)CER</sub>	The breakdown voltage between the collector and emitter terminals under specified test conditions when a resistor is connected between the base and emitter terminals	
	V <sub>(BR)CEX</sub>	The breakdown voltage between the collector and emitter terminals under specified test conditions when a reverse bias is applied between the base and emitter terminals	
	V <sub>(BR)CES</sub>	The breakdown voltage between the collector and emitter terminals under specified test conditions when the base and emitter terminals are short-circuited	
Emitter-base breakdown voltage	V <sub>(BR)EBO</sub>	The breakdown voltage between the emitter and base terminals under specified test conditions when the collector terminal is open-circuited	
Collector-base cut-off current	I <sub>CBO</sub>	The current in the cut-off state that flows into the collector terminal under specified test conditions when a voltage is applied across the collector and base terminals with the emitter terminal open-circuited	
Collector-emitter cut-off current	I <sub>CEO</sub>	The current in the cut-off state that flows into the collector terminal under specified test conditions when a voltage is applied between the collector and emitter terminals with the base terminal open-circuited	
Emitter-base cut-off current	I <sub>EBO</sub>	The current in the cut-off state that flows into the emitter terminal under specified test conditions when a voltage is applied between the emitter and base terminals with the collector terminal open-circuited	
DC current gain	h <sub>FE</sub>	The ratio of the collector current to the base current in a common-emitter configuration under specified test conditions DC current gain = collector current / base current	



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Term	Symbol	Description	
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	The voltage between the collector and emitter terminals in the saturation state under specified test conditions	
Base-emitter saturation voltage	V <sub>BE(sat)</sub>	The voltage between the base and emitter terminals in the saturation state under specified test conditions	
Collector output capacitance	C <sub>ob</sub>	The capacitance between collector and base at the specified collector-base voltage and frequency when the emitter terminal is open-circuited	
Emitter input capacitance	C <sub>ib</sub>	The capacitance value between emitter and base at the specified emitter-base voltage and frequency when the base terminal is grounded	
Reverse capacitance	C <sub>re</sub>	The capacitance value when the input is ac short-circuited and the emitter terminal is grounded	
Transition frequency	f <sub>T</sub>	The frequency at which the current gain is 1 (= 0 dB) when the emitter is grounded	
Noise figure	NF	The ratio of the input signal-to-noise ratio to the output signal-to-noise ratio of a device. NF is calculated as: $NF = 10  \log \left[  \frac{(S/N)_{\ in}}{(S/N)_{\ out}} \right]^2$	



Term	Symbol	Desc	cription
Delay time	t <sub>d</sub>	The period of time from when the base current has reached 10% of its maximum amplitude to when the collector-emitter voltage has reached 90% of its maximum amplitude, or the period of time required for the collector current to reach 10% of its maximum amplitude	Definition of collector-emitter voltage ( $V_{CE}$ )
Rise time	t <sub>r</sub>	The period of time required for the collector-emitter voltage to decrease from 90% to 10% of its maximum amplitude, or the period of time required for the collector current to increase from 10% to 90% of its maximum amplitude	0 10% 10% 10% VCE ': Maximum amplitude of VCE
Turn-on time	t <sub>on</sub>	The period of time from when the base current has reached 10% of its maximum amplitude to when the collector-emitter voltage has reached 10% of its maximum amplitude, or the period of time required for the collector current to reach 90% of its maximum amplitude	Definition of collector current ( $I_C$ ) $I_B = 0 \qquad \qquad$
Storage time	t <sub>stg</sub>	The period of time from when base current has dropped to 90% of its maximum amplitude to when the collector-emitter voltage has reached 10% of its maximum amplitude, or the period of time from when the base current has dropped to 90% of its maximum amplitude to when the collector-emitter voltage has reached 90% of its maximum amplitude	I <sub>C</sub> ': Maximum amplitude of I <sub>C</sub>



Term	Symbol	Description	
Fall time	t <sub>f</sub>	The period of time required for the collector-emitter voltage to increase from 10% to 90% of its maximum amplitude, or the period of time required for the collector current to decrease from 90% to 10% of	
Turn-off time	t <sub>off</sub>	its maximum amplitude  The period of time from when the base current has reached 90% of its maximum amplitude to when the collector-emitter voltage has reached 90% of its maximum amplitude, or the time required for the collector current to reach 10% of its maximum amplitude	

#### 1.3. Other terms

Term	Description		
Cut-off region	The region where almost no collector current flows when the base and emitter are open-circuited, short-circuited, or reverse-biased	Saturation	
Active region	The region where the collector current changes in proportion to the base current applied	Ic Active	
Saturation region	In this region, even if the base current is increased or decreased, the collector current on the load line hardly changes (Point A in the figure) and the collector current changes only when the collector-emitter voltage is changed.	Cut-off V <sub>CE</sub>	
Forward-bias safe operating area	The region specified by the collector current and collector-emitter voltage conditions where a transistor operates without self-damage when the base -emitter is forward-biased		
Reverse-bias safe operating area	The region bounded by the collector current and collector-emitter voltage conditions where a transistor can safely transition to the cut-off region from the "on" state without self-damage when the base-emitter is reverse-biased		



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